



Attorney Docket No. 2003-042
PATENT

CERTIFICATE OF MAILING

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BY:

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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of: Charmot et al.
Serial No.: 10/609,255
Filed: 6/26/2003
For: Removal of the Thiocarbonylthio or Thiophosphorylthio End Group of Polymers And Further Functionalization Thereof

Confirmation No. 7767
Group Art Unit: 1711
Examiner: O. Asinovsky

Santa Clara, California
December 14, 2004

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT

Sir:

Applicants request that the references cited herein be considered in connection with the examination of this application. The references are listed on the attached PTO-1449 form.

This is being filed after the first office action, and thus Applicants are paying the fee required by 37 CFR § 1.17(p) in the accompanying transmittal letter.

Respectfully submitted,

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INFORMATION DISCLOSURE CITATION PTO-1449			ATTORNEY'S DOCKET NO.:		APPLICATION NO.:	
			2003-042		10/609,255	
			APPLICANT: Charmot et al.			
			FILING DATE: June 26, 2003		GROUP: 1711	
US PATENT DOCUMENTS						
EXAMINER'S INITIALS	PATENT NO.	DATE	NAME	CLASS	SUBCLASS	FILING DATE
	2002-0058770		Charmot et al.	526	194	9/25/01
	2002-0061990		Charmot et al.	526	205	5/22/01
	2003-0092834		Charmot et al.	525	54.2	7/20/01
	2003-0232938		Charmot et al.	526	194	4/3/03
	2003-0232939		Charmot et al.	526	218.1	4/3/03
	2004-0019163		Charmot et al.	526	198	4/3/03
	3,580,830	5/25/71	Siebert	204	159.24	9/5/68
	5,089,601	2/18/92	Ozoe et al.	528	390	9/7/90
	5,314,962	5/24/94	Otsu et al.	525	280	6/29/93
	5,356,947	10/18/94	Ali et al.	522	57	10/29/92
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	6,767,968	7/27/04	Liu et al.	525	242	10/3/00
EXAMINER:			DATE CONSIDERED:			

Examiner: Initial if reference considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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FOREIGN DOCUMENTS							
EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUB CLASS	TRANSLATION	
						Yes	No
	EP 0 349 232	1/3/90	EPC	C08F	293/00		X
	EP 0 421 149	4/10/91	EPC	C08F	36/18		X
	EP 0 449 619	10/2/91	EPC	C09J	201/00		X
	WO 00/75207	12/14/00	PCT	C08F	293/00		X
	WO 02/090397	11/14/02	PCT	C08F	8/00	X	
	WO 02/090409	11/14/02	PCT	C08F	293/00		X
	WO 02/28932	4/11/02	PCT	C08F	293/00		X
	WO 98/10478	1/15/98	PCT	C08F	2/38		X
	WO 98/58974	12/30/98	PCT	C08F	293/00	X	
	WO 99/05099	2/4/99	PCT	C07C	327/36		X
	WO 99/31144	6/24/99	PCT	C08F	2/38		X
	WO 99/33003	7/1/99	PCT	G06F	17/30		X
	WO 99/35177	7/15/99	PCT	C08F	293/00		
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OTHER DOCUMENTS (including Author, Title, Date, Pertinent Pages Etc.)		
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	International Search Report and Written Opinion of the International Searching Authority (Laura Fernandez Gomez, European Patent Office) dated September 14, 2004, Application No. PCT/US2004/010014	
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